
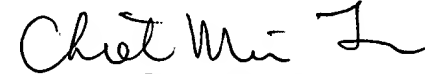



Issue Classification 	Application/Control No.		Applicant(s)/Patent under Reexamination	
	09/818,252		STACEY ET AL.	
	Examiner		Art Unit	
	Eva Yi Zheng		2611	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
375		222		375	224				
INTERNATIONAL CLASSIFICATION				370	503	505	282		
H	0	4	L	5/16					
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Eva Zheng 1/18/07 (Assistant Examiner) (Date)		 CHIEH M. FAN SUPERVISORY PATENT EXAMINER (Primary Examiner) (Date) 1/19/07	Total Claims Allowed: 6	
 (Legal Instruments Examiner) (Date)			O.G. Print Claim(s) 6	O.G. Print Fig. 2

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant					<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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